

2018年5月15日星期二

HUAWEI ENTERPRISE A BETTER WAY

Backfeed Test

Author/ ID: Shiyong Fu/00184310

Yan Zhuang/00206596

Rui Hua/00391617

Dept: Ethernet Switch Product Field.

Version: V1.0(20180518)

enterprise.huawei.com

HUAWEI TECHNOLOGIES CO., LTD.



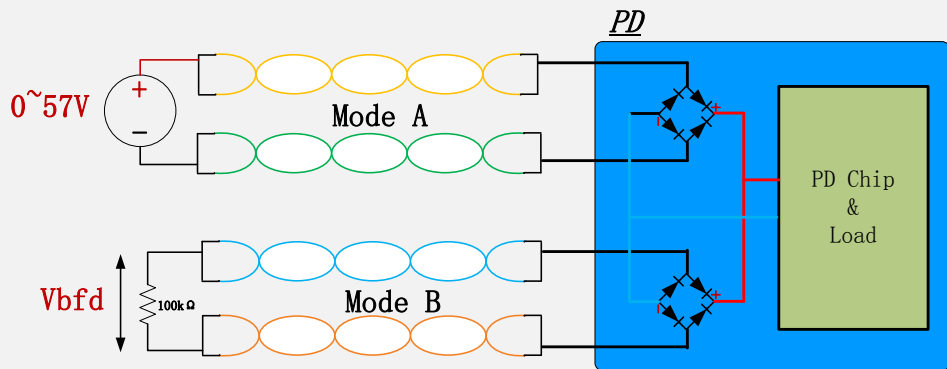
Backfeed Test Model

Put the PD with Discrete Schottky diode bridge into the incubator

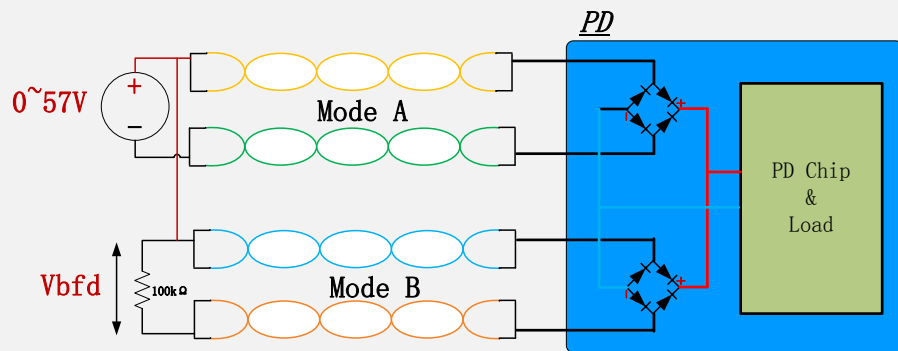
Set the temperature of the incubator

Test the V_{bfd} of one positive pair PD and two positive pair PD

One positive pair



Two positive pair



Backfeed Test Result

Test Model	Incubator temperature/0°C		Incubator temperature/25°C		Incubator temperature/45°C		Incubator temperature/65°C	
	Vbfd/V	Tdiode/°C	Vbfd/V	Tdiode/°C	Vbfd/V	Tdiode/°C	Vbfd/V	Tdiode/°C
one positive pair, 10.1V	0	0.2	0	25	0	44.1	0.003	66.4
two positive pair, 10.1V	0.04	0.2	0.052	25	0.067	44	0.096	66.4
one positive pair, 21V	0	0.3	0	25.1	0.001	44.4	0.004	66.7
two positive pair, 21V	0.222	0.4	0.238	25.1	0.248	44.3	0.281	66.6
one positive pair, 30V	0	0.4	0	25.1	0.001	44.6	0.006	66.4
two positive pair, 30V	0.226	0.4	0.243	25.1	0.252	44.7	0.288	66.5
one positive pair, 57V	0	4.4	0.001	28.1	0.004	48.5	0.017	69.5
two positive pair, 57V	0.368	4.6	0.398	28.1	0.416	48.5	0.486	69.5

Test results shows that the **Vbfd(0V~57V)** of Schottky diodes bridge have no problem under 3p.

Thank you!